


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>09424684</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>INANAGA ET AL.</p>
	<p>Examiner</p> <p>DEVONA E FAULK</p>	<p>Art Unit</p> <p>2615</p>

SEARCHED			
Class	Subclass	Date	Examiner
381	307,309,31-,17-23	6/9/05	BTP
	updated search	3/9/06	BTP
381	307,309,17,22	3/16/07	DEF
381	74,307,309,310,17-23	1/2/08,2/27/08	DEF
700	94	2/27/08	DEF
381	307,309,17-23,102-109,310	10/14,21,23/08	DEF
381	1	10/27/08	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
assignee/inventor search	3/16/07	DEF
additional search	1/2/08, 2/27,29/08	DEF
consulted with Ping Lee	2/29/08	DEF
additonal search	10/14,21/08	DEF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
381	307-310,17-23,1	3/16/07, 2/27/08, 10/27/08	DEF

	<p>/DEVONA E FAULK/ Examiner,Art Unit 2615</p>
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